



# Product data sheet

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SOT - 23



2. EMITTER

3. COLLECTOR

MMBTA06 TRANSISTOR (NPN)

#### **FEATURES**

- For Switching and Amplifier Applications
- Complementary Type PNP Transistor MMBTA56

**MARKING: 1GM** 

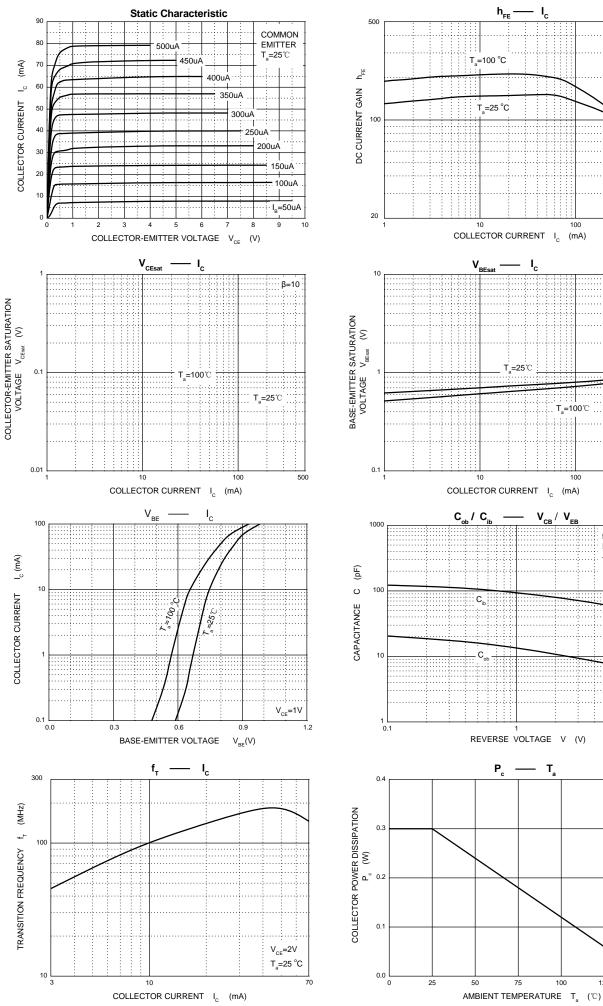
Symbol	Parameter	Value	Unit
V <sub>сво</sub>	Collector-Base Voltage	80	V
VCEO	Collector-Emitter Voltage	80	V
V <sub>EBO</sub>	Emitter-Base Voltage	4	V
lc	Collector Current	500	mA
Pc	Collector Power Dissipation	300	mW
R <sub>oja</sub>	Thermal Resistance From Junction To Ambient	416	°C/W
T <sub>J</sub> ,T <sub>stg</sub>	Operation Junction and Storage Temperature Range	-55~+150	°C

#### MAYIMUM DATINGS (T

### ELECTRICAL CHARACTERISTICS (T<sub>a</sub>=25°C unless otherwise specified)

Parameter	Symbol	Test conditions	Min	Тур	Max	Unit
Collector-base breakdown voltage	V <sub>(BR)CBO</sub>	I <sub>C</sub> =0.1mA, I <sub>E</sub> =0	80			V
Collector-emitter breakdown voltage	V <sub>(BR)CEO</sub>	I <sub>C</sub> =1mA, I <sub>B</sub> =0	80			V
Emitter-base breakdown voltage	V <sub>(BR)EBO</sub>	I <sub>E</sub> =0.1mA, I <sub>C</sub> =0	4			V
Collector cut-off current	I <sub>СВО</sub>	V <sub>CB</sub> =80V, I <sub>E</sub> =0			0.1	μA
Collector cut-off current	I <sub>CEO</sub>	V <sub>CE</sub> =60V, I <sub>B</sub> =0			1	μA
Emitter cut-off current	I <sub>EBO</sub>	V <sub>EB</sub> =3V, I <sub>C</sub> =0			0.1	μA
DC current gain	$h_{FE(1)}$	V <sub>CE</sub> =1V, I <sub>C</sub> =10mA	100		400	
	h <sub>FE(2)</sub>	V <sub>CE</sub> =1V, I <sub>C</sub> =100mA	100			
Collector-emitter saturation voltage	V <sub>CE(sat)</sub>	I <sub>C</sub> =100mA, I <sub>B</sub> =10mA			0.25	V
Base-emitter saturation voltage	V <sub>BE(sat)</sub>	I <sub>C</sub> =100mA, I <sub>B</sub> =10mA			1.2	V
Transition frequency	f⊤	V <sub>CE</sub> =2V,I <sub>C</sub> =10mA, f=100MHz	100			MHz



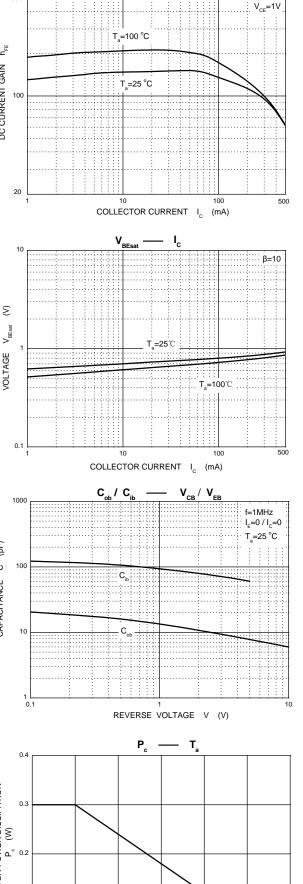




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h<sub>FE</sub>

– I<sub>c</sub>



150

100

50

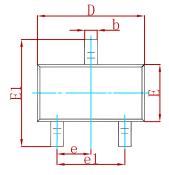
75

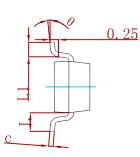
125

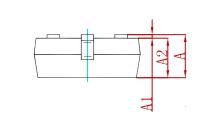




## PACKAGE MECHANICAL DATA

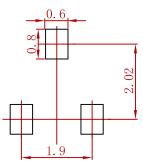






Symbol	Dimensions In Millimeters		Dimensions In Inches		
Symbol	Min	Max	Min	Max	
Α	0.900	1.150	0.035	0.045	
A1	0.000	0.100	0.000	0.004	
A2	0.900	1.050	0.035	0.041	
b	0.300	0.500	0.012	0.020	
с	0.080	0.150	0.003	0.006	
D	2.800	3.000	0.110	0.118	
E	1.200	1.400	0.047	0.055	
E1	2.250	2.550	0.089	0.100	
е	0.950 TYP		0.037	7 TYP	
e1	1.800	2.000	0.071	0.079	
L	0.550 REF		0.022 REF		
L1	0.300	0.500	0.012	0.020	
θ	0°	8°	0°	8°	

## Suggested Pad Layout



Note:

Controlling dimension:in millimeters.
General tolerance:± 0.05mm.
The pad layout is for reference purposes only.

## **REEL SPECIFICATION**

P/N	PKG	QTY
MMBTA06	SOT-23	3000





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